

Notice of References Cited

Application/Control No.

10/628,827

Applicant(s)/Patent Under
Reexamination
HENSON ET AL.

Examiner

Devona E. Faulk

Art Unit

2615

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,796,851	08-1998	Hewitt et al.	381/94.5
*	B	US-5,764,005	06-1998	Kobayashi, Masaki	315/382
*	C	US-6,783,073	08-2004	Yahagi et al.	235/462.28
*	D	US-6,281,821	08-2001	Rhode et al.	341/144
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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